PSMN017-30PL



N-channel 30 V 17 m Ω logic level MOSFET in TO220 Rev. 2 — 3 April 2012 Produc

Product data sheet

1. **Product profile**

1.1 General description

Logic level N-channel MOSFET in TO220 package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Suitable for logic level gate drive sources

1.3 Applications

- DC-to-DC converters
- Load switching

- Motor control
- Server power supplies

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	-	30	V
I_D	drain current	T _{mb} = 25 °C; V _{GS} = 10 V; see <u>Figure 1</u> [1]	-	-	32	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	-	45	W
Tj	junction temperature		-55	-	175	°C
Static chara	acteristics					
R _{DSon}	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V}; I_D = 10 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see Figure 13	-	18.7	23.4	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see Figure 13	-	13.4	17	mΩ
Dynamic cl	haracteristics					
Q_{GD}	gate-drain charge	$V_{GS} = 4.5 \text{ V}; I_D = 10 \text{ A}; V_{DS} = 15 \text{ V};$ see <u>Figure 14</u> ; see <u>Figure 15</u>	-	1.94	-	nC
Q _{G(tot)}	total gate charge	$V_{GS} = 4.5 \text{ V}; I_D = 10 \text{ A}; V_{DS} = 15 \text{ V};$ see Figure 14; see Figure 15	-	5.1	-	nC
Avalanche	ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 32 A; V_{sup} ≤ 30 V; R_{GS} = 50 Ω ; unclamped	-	-	13	mJ

^[1] Continuous current is limited by package.



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		_
2	D	drain	mb	D
3	S	source		
mb	D	mounting base; connected to drain	1 2 3	mbb076 S
			SOT78 (TO-220AB)	

3. Ordering information

Table 3. Ordering information

Type number	e number Package				
	Name	Description	Version		
PSMN017-30PL	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78		

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Parameter	Conditions		Min	Max	Unit
drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	30	V
drain-gate voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$		-	30	V
gate-source voltage			-20	20	V
drain current	V _{GS} = 10 V; T _{mb} = 100 °C; see <u>Figure 1</u>	[1]	-	26.9	Α
	V _{GS} = 10 V; T _{mb} = 25 °C; see <u>Figure 1</u>	[1]	-	32	Α
peak drain current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 °C$; see <u>Figure 3</u>		-	152	Α
total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	45	W
storage temperature			-55	175	°C
junction temperature			-55	175	°C
diode					
source current	T _{mb} = 25 °C		-	32	Α
peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$		-	152	Α
ggedness					
non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 32 A; $V_{sup} \le$ 30 V; R_{GS} = 50 Ω ; unclamped		-	13	mJ
	drain-source voltage drain-gate voltage gate-source voltage drain current peak drain current total power dissipation storage temperature junction temperature diode source current peak source current ggedness non-repetitive drain-source	$\begin{array}{lll} \text{drain-source voltage} & T_{j} \geq 25 \ ^{\circ}\text{C}; \ T_{j} \leq 175 \ ^{\circ}\text{C} \\ \text{drain-gate voltage} & T_{j} \geq 25 \ ^{\circ}\text{C}; \ T_{j} \leq 175 \ ^{\circ}\text{C}; \ R_{GS} = 20 \ k\Omega \\ \text{gate-source voltage} \\ \text{drain current} & V_{GS} = 10 \ \text{V}; \ T_{mb} = 100 \ ^{\circ}\text{C}; \ \text{see Figure 1} \\ \hline V_{GS} = 10 \ \text{V}; \ T_{mb} = 25 \ ^{\circ}\text{C}; \ \text{see Figure 1} \\ \text{peak drain current} & \text{pulsed}; \ t_{p} \leq 10 \ \mu\text{s}; \ T_{mb} = 25 \ ^{\circ}\text{C}; \ \text{see Figure 3} \\ \text{total power dissipation} & T_{mb} = 25 \ ^{\circ}\text{C}; \ \text{see Figure 2} \\ \text{storage temperature} & \text{junction temperature} \\ \hline \textbf{diode} & \text{source current} & T_{mb} = 25 \ ^{\circ}\text{C} \\ \text{peak source current} & \text{pulsed}; \ t_{p} \leq 10 \ \mu\text{s}; \ T_{mb} = 25 \ ^{\circ}\text{C} \\ \hline \textbf{ggedness} & \text{non-repetitive drain-source} & V_{GS} = 10 \ \text{V}; \ T_{j(init)} = 25 \ ^{\circ}\text{C}; \ I_{D} = 32 \ \text{A}; \\ \hline \end{array}$	$\begin{array}{lll} drain\text{-source voltage} & T_j \geq 25 \ ^\circ\text{C}; \ T_j \leq 175 \ ^\circ\text{C} \\ drain\text{-gate voltage} & T_j \geq 25 \ ^\circ\text{C}; \ T_j \leq 175 \ ^\circ\text{C}; \ R_{GS} = 20 \ k\Omega \\ \\ gate\text{-source voltage} \\ drain current & V_{GS} = 10 \ \text{V}; \ T_{mb} = 100 \ ^\circ\text{C}; \ see \ \underline{Figure} \ 1 \\ \hline V_{GS} = 10 \ \text{V}; \ T_{mb} = 25 \ ^\circ\text{C}; \ see \ \underline{Figure} \ 1 \\ \hline V_{GS} = 10 \ \text{V}; \ T_{mb} = 25 \ ^\circ\text{C}; \ see \ \underline{Figure} \ 1 \\ \hline Peak \ drain \ current & pulsed; \ t_p \leq 10 \ \mu\text{s}; \ T_{mb} = 25 \ ^\circ\text{C}; \ see \ \underline{Figure} \ 3 \\ \hline total \ power \ dissipation & T_{mb} = 25 \ ^\circ\text{C}; \ see \ \underline{Figure} \ 2 \\ \hline storage \ temperature & \\ \hline diode & \\ \hline source \ current & T_{mb} = 25 \ ^\circ\text{C} \\ \hline peak \ source \ current & pulsed; \ t_p \leq 10 \ \mu\text{s}; \ T_{mb} = 25 \ ^\circ\text{C} \\ \hline ggedness & \\ \hline non-repetitive \ drain\text{-source} & V_{GS} = 10 \ \text{V}; \ T_{j(init)} = 25 \ ^\circ\text{C}; \ I_D = 32 \ \text{A}; \\ \hline \end{array}$	$\begin{array}{llllllllllllllllllllllllllllllllllll$	drain-source voltage $T_j \ge 25 ^{\circ}\text{C}; \ T_j \le 175 ^{\circ}\text{C}$ - 30 drain-gate voltage $T_j \ge 25 ^{\circ}\text{C}; \ T_j \le 175 ^{\circ}\text{C}; \ R_{GS} = 20 \text{k}\Omega$ - 30 gate-source voltage -20 20 drain current $V_{GS} = 10 \text{V}; \ T_{mb} = 100 ^{\circ}\text{C}; \ \text{see Figure 1}$ 11 - 26.9 $V_{GS} = 10 \text{V}; \ T_{mb} = 25 ^{\circ}\text{C}; \ \text{see Figure 1}$ 11 - 32 peak drain current pulsed; $t_p \le 10 \mu\text{s}; \ T_{mb} = 25 ^{\circ}\text{C}; \ \text{see Figure 3}$ - 152 total power dissipation $T_{mb} = 25 ^{\circ}\text{C}; \ \text{see Figure 2}$ - 45 storage temperature -55 175 junction temperature -55 175 diode source current $T_{mb} = 25 ^{\circ}\text{C}; \ \text{see Figure 2}$ - 32 peak source current pulsed; $t_p \le 10 \mu\text{s}; \ T_{mb} = 25 ^{\circ}\text{C}$ - 32 peak source current pulsed; $t_p \le 10 \mu\text{s}; \ T_{mb} = 25 ^{\circ}\text{C}$ - 152 aggedness non-repetitive drain-source $V_{GS} = 10 \text{V}; \ T_{j(init)} = 25 ^{\circ}\text{C}; \ I_D = 32 \text{A};$ - 13

[1] Continuous current is limited by package.

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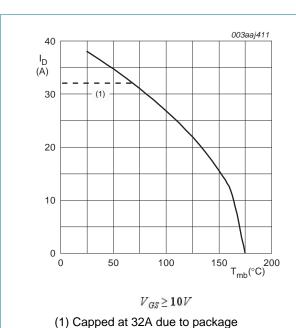


Fig 1. Continuous drain current as a function of mounting base temperature

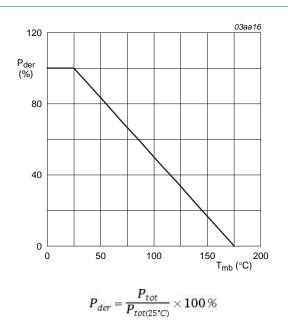
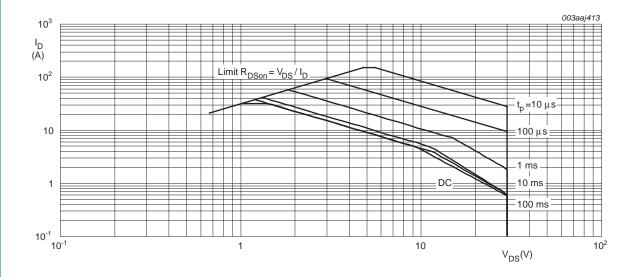


Fig 2. Normalized total power dissipation as a function of mounting base temperature



 $T_{mb} = 25^{\circ}C$; I_{DM} is a single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	3.24	3.31	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	vertical in free air	-	60	-	K/W

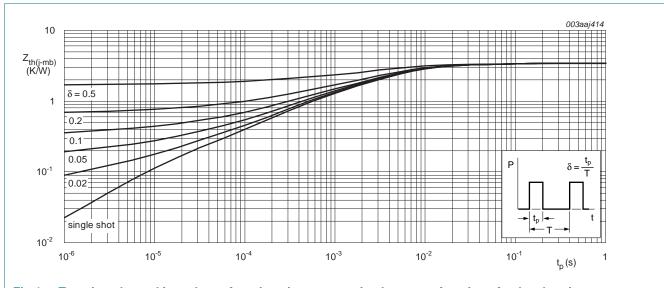


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	30	-	-	V
		$I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 °C$	27	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 25$ °C; see <u>Figure 10</u> ; see <u>Figure 11</u>	1.3	1.7	2.15	V
		I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 175 °C; see <u>Figure 11</u>	0.5	-	-	V
		I_D = 1 mA; V_{DS} = V_{GS} ; T_j = -55 °C; see <u>Figure 11</u>	-	-	2.45	V
I _{DSS}	drain leakage current	$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.3	1	μΑ
		$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125 \text{ °C}$	-	-	50	μΑ
I _{GSS}	gate leakage current	$V_{GS} = 16 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nA
		$V_{GS} = -16 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nA
R _{DSon}	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V}; I_D = 10 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see <u>Figure 12</u>	-	-	43.2	mΩ
		$V_{GS} = 4.5 \text{ V}; I_D = 10 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see Figure 13	-	18.7	23.4	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see Figure 12	-	24	31.5	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 100 \text{ °C};$ see Figure 12	-	-	23.5	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 25 \text{ °C};$ see Figure 13	-	13.4	17	mΩ
R_G	gate resistance	f = 1 MHz	-	2.03	-	Ω
Dynamic o	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 10 \text{ A}$; $V_{DS} = 15 \text{ V}$; $V_{GS} = 10 \text{ V}$; see Figure 14; see Figure 15	-	10.7	-	nC
		$I_D = 0 \text{ A}$; $V_{DS} = 0 \text{ V}$; $V_{GS} = 10 \text{ V}$; see Figure 14; see Figure 15	-	9.55	-	nC
		I_D = 10 A; V_{DS} = 15 V; V_{GS} = 4.5 V; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	5.1	-	nC
Q _{GS}	gate-source charge	$I_D = 10 \text{ A}; V_{DS} = 15 \text{ V}; V_{GS} = 4.5 \text{ V};$	-	1.52	-	nC
Q _{GS(th)}	pre-threshold gate-source charge	see <u>Figure 14</u> ; see <u>Figure 15</u>	-	1	-	nC
Q _{GS(th-pl)}	post-threshold gate-source charge		-	0.5	-	nC
Q_{GD}	gate-drain charge		-	1.94	-	nC
$V_{GS(pl)}$	gate-source plateau voltage	$I_D = 10 \text{ A}$; $V_{DS} = 15 \text{ V}$; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	2.86	-	V
C _{iss}	input capacitance	V _{DS} = 15 V; V _{GS} = 0 V; f = 1 MHz;	-	552	-	pF
C _{oss}	output capacitance	T _j = 25 °C; see <u>Figure 16</u>	-	127	-	pF
C _{rss}	reverse transfer capacitance		-	64	-	pF

Table 6. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
t _{d(on)}	turn-on delay time	$V_{DS} = 15 \text{ V}; R_L = 1.5 \Omega; V_{GS} = 4.5 \text{ V};$	-	10.7	-	ns
t _r	rise time	$R_{G(ext)} = 5 \Omega$	-	9.2	-	ns
t _{d(off)}	turn-off delay time		-	11.4	-	ns
t _f	fall time		-	5.1	-	ns
Source-dra	ain diode					
V_{SD}	source-drain voltage	$I_S = 10 \text{ A}$; $V_{GS} = 0 \text{ V}$; $T_j = 25 \text{ °C}$; see Figure 17	-	0.89	1.2	V
t _{rr}	reverse recovery time	$I_S = 10 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s};$	-	17.3	-	ns
Q _r	recovered charge	$V_{GS} = 0 \text{ V}; V_{DS} = 15 \text{ V}$	-	6.5	-	nC

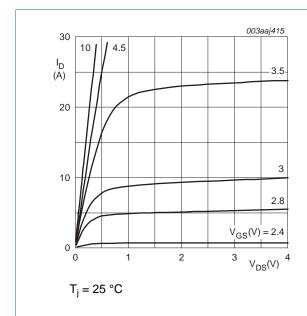


Fig 5. Output characteristics; drain current as a function of drain-source voltage; typical values

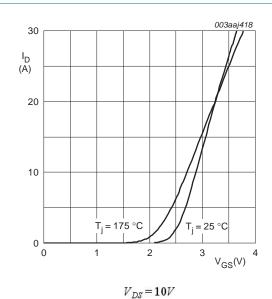


Fig 6. Transfer characteristics; drain current as a function of gate-source voltage; typical values

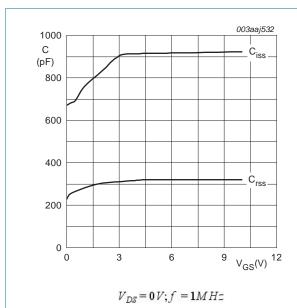


Fig 7. Input and reverse transfer capacitances as a function of gate-source voltage; typical values

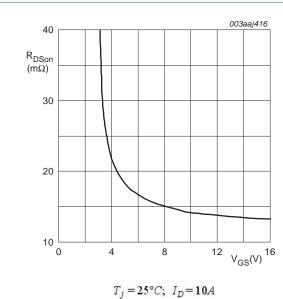


Fig 9. Drain-source on-state resistance as a function of gate-source voltage; typical values

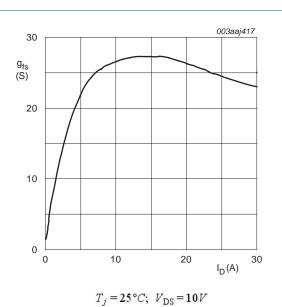
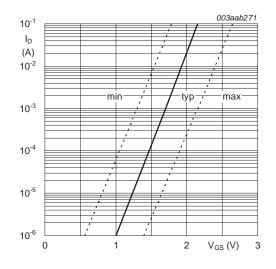


Fig 8. Forward transconductance as a function of drain current; typical values



 $T_j = 25\,^{\circ}C; V_{DS} = 5V$

Fig 10. Sub-threshold drain current as a function of gate-source voltage

2

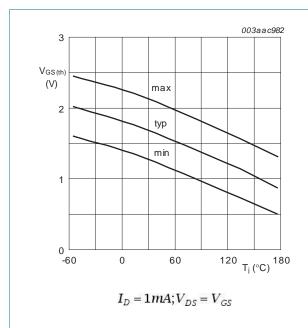
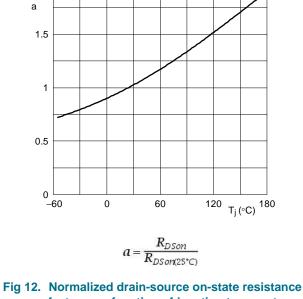


Fig 11. Gate-source threshold voltage as a function of junction temperature



factor as a function of junction temperature

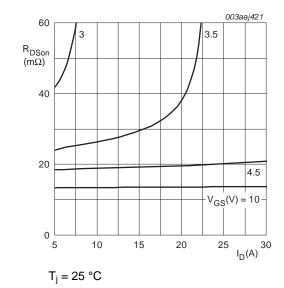


Fig 13. Drain-source on-state resistance as a function of drain current; typical values

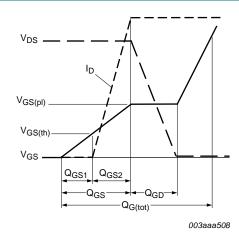


Fig 14. Gate charge waveform definitions

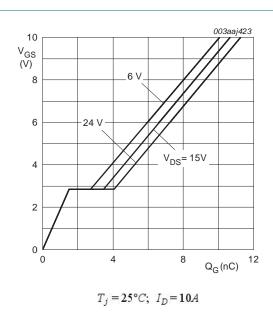
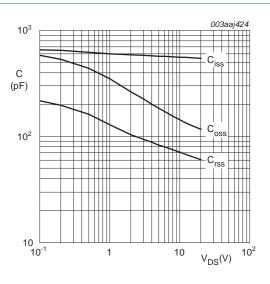
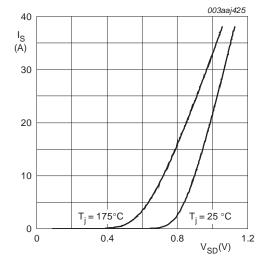


Fig 15. Gate-source voltage as a function of gate charge; typical values



 $V_{GS} = \mathbf{0}V; \ f = \mathbf{1}MHz$

Fig 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



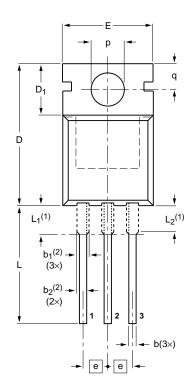
 $V_{GS} = \mathbf{0} V$

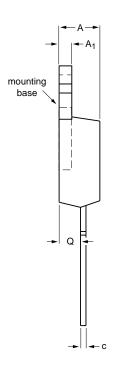
Fig 17. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

7. Package outline



SOT78





0 5 10 mm

DIMENSIONS (mm are the original dimensions)

UNI	ГА	A ₁	b	b ₁ (2)	b ₂ (2)	С	D	D ₁	E	е	L	L ₁ (1)	L ₂ ⁽¹⁾ max.	р	q	Q	
mm	4.7 4.1	1.40 1.25	0.9 0.6	1.6 1.0	1.3 1.0	0.7 0.4	16.0 15.2	6.6 5.9	10.3 9.7	2.54	15.0 12.8	3.30 2.79	3.0	3.8 3.5	3.0 2.7	2.6 2.2	

Notes

- 1. Lead shoulder designs may vary.
- 2. Dimension includes excess dambar.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT78		3-lead TO-220AB	SC-46	$ \ \ \bigoplus \bigoplus$	08-04-23 08-06-13

Fig 18. Package outline SOT78 (TO-220AB)

PSMN017-30PL

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8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN017-30PL v.2	20120403	Product data sheet	-	PSMN017-30PL v.1
Modifications:	Status changed Narious shanged			
	 Various change 	es to content.		
PSMN017-30PL v.1	20120228	Objective data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status[1] [2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URLhttp://www.nxp.com.

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PSMN017-30PL

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PSMN017-30PL

N-channel 30 V 17 mΩ logic level MOSFET in TO220

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